

**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

SJ 20788-2000

**Measurment method for thermal impedance of semiconductor
diodes**

半导体二极管热阻抗测试方法

(English Translation)

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What this standard covers

This standard specifies the steady-state thermal resistance and semiconductor diode transient thermal impedance testing methods. This standard applies to rectifier diodes, transient voltage suppression diodes, zener diode and some power zener, signaling and switching diodes steady state and transient thermal resistance obstruction tests.

Document data

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